


<b>Search Notes</b>  	<b>Application/Control No.</b>  10522324	<b>Applicant(s)/Patent Under Reexamination</b>  DAVIES, MICHAEL BIRSHA
	<b>Examiner</b>  KRISTEN C MATTER	<b>Art Unit</b>  3771

SEARCHED			
Class	Subclass	Date	Examiner
128	200.14, 200.19, 200.23, 203.15, 203.16, 203.12, 203.19, 203.21-203.25	7/22/08	KCM

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name search	7/22/08	KCM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner